

# HASO SWIR

Wavefront sensor The InGaAs

High accuracy SWIR range Alignment-free







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# HASO SWIR +

A great choice for short wavelength infrared applications, ideal for industry and laboratories.

This generation features the new SpotTracker<sup>™</sup> technology. It provides absolute wavefront and tilt information, eliminating alignment requirements for faster and easier implementation.



Compatible with the Optical Engineer Companion modular system: easily combine the accessories you need.

# **APPLICATIONS**

Successfully used in the most demanding applications in optical metrology, microscopy, and laser diagnostics, the HASO SWIR performs multiple functions:

+ Quantify aberrations in optical systems for LIDAR, free-space communication, space and defense, etc.

- + Align the system to ensure that it performs at its best
- + Predict the performance of optical systems in terms of focusing capability (PSF) or imaging quality (MTF)
- + Verify that the optics comply with specifications
- + Directly measure the optical system's wavelength dependency
- + Drive a wavefront corrector to correct for system aberrations
- + Check whether the optical mount overly distorts the optics
- + Diagnostic of ultra-short-pulses with the Gated version

### **FEATURES**

- + Laser beam deviation control better than 3 µrad RMS
- + Collimation diagnostic up to curvature radii over 300m
- + Live wavefront acquisition. Measurement accuracy  $\lambda$ /100 RMS guaranteed for beams down to F/5
- + True tilt measurement, curvature, astigmatism and high-order aberrations quantification
- + Optionnal Gated version with ultra-short exposure time feature to synchronize with a pulsed laser.



# **SPECIFICATIONS\***

#### **OPERATING SPECS**

Aperture dimension Number of microlenses Maximum acquisition frequency Calibrated wavelength range Minimum power External trigger Operating system

#### **OPTICAL SPECS**

Repeatability Absolute wavefront measurement accuracy Spatial sampling Tilt dynamic range Focus dynamic range

#### MISC

Dimensions (Height x Width x Length) Weight for USB version Working temperature Interface Power consumption Exposure time of Gated version 9.30 x 7.44 mm<sup>2</sup> 40 x 32 150 Hz (USB 3.0) or 49 Hz (GigE) 0.9 - 1.7 μm 0.3 pW TTL signal Windows 10

λ/200 RMS λ/100 RMS ~ 232.5 μm > ± 3° ± 0.017 m to ± ∞

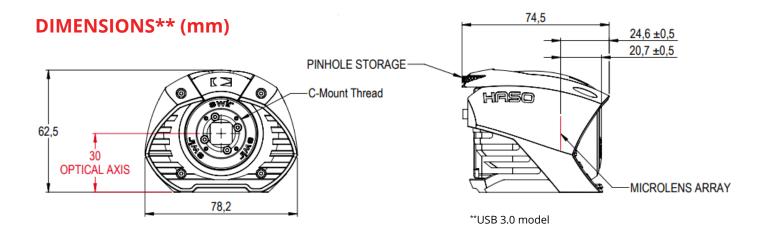
75 x 78 x 63 mm<sup>3</sup> 250 g 15 - 30 °C USB 3.0 or GigE < 5 W 100 ns - 9 μs





**HASD SWIR** Dynamic range at  $\lambda$  = 1550 nm

\*Subject to changes without further notice



## **SOFTWARE**

#### WAVEVIEW<sup>™</sup> Metrology Software

WAVEVIEW<sup>™</sup> is the most advanced wavefront measurement and analysis software.

It offers more than 150 features and tools optimized for a wide range of highly demanding applications.

#### **Options :**

+ Extensions for PSF, MTF and Strehl ratio

+ Optional SDK in C/C++, LabVIEW and Python

#### WAVETUNE<sup>™</sup> Adaptive Optics Software

WAVETUNE<sup>™</sup> is a unique software that seamlessly combines wavefront measurement and correction features with extensive instrument diagnostics. It is perfectly adapted to our HASO wavefront sensors, ILAO STAR, MIRAO and mu-DM deformable mirrors, as well as to a wide range of active components.

#### **Options**:

+ Optional SDK in C/C++, LabVIEW and Python

